## Application/Control No. Applicant(s)/Patent Under Reexamination TANIOKA ET AL Examiner Art Unit

Examiner

Jennifer R. Sadula

Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,907,005	05-1999	SHIMIZU	524/104
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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